SN54ALS652, SN54ALS653, SN54AS651, SN54AS652 SN74ALS651A, SN74ALS652A, SN74ALS653, SN74ALS654, SN74AS651, SN74AS652 OCTAL BUS TRANSCEIVERS AND REGISTERS WITH 3-STATE OUTPUTS SDAS066G – DECEMBER 1983 – REVISED DECEMBER 2000

SN

- Bus Transceivers/Registers
- Independent Registers and Enables for A and B Buses
- Multiplexed Real-Time and Stored Data
- Choice of True or Inverting Data Paths
- Choice of 3-State or Open-Collector Outputs to A Bus

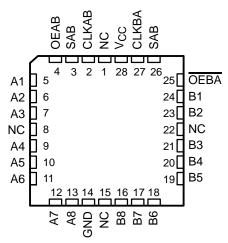
DEVICE	A OUTPUT	B OUTPUT	LOGIC
SN74ALS651A, 'AS651	3-State	3-State	Inverting
SN54ALS652, SN74ALS652A, 'AS652	3-State	3-State	True
'ALS653	Open Collector	3-State	Inverting
SN74ALS654	Open Collector	3-State	True

description

These devices consist of bus-transceiver circuits, D-type flip-flops, and control circuitry arranged for multiplexed transmission of data directly from the data bus or from the internal storage registers. Output-enable (OEAB and OEBA) inputs are provided to control the transceiver functions. Select-control (SAB and SBA) inputs are provided to select real-time or stored data transfer. The circuitry used for select control eliminates the typical decoding glitch that occurs in a multiplexer during the transition between stored and real-time data. A low input level selects real-time data, and a high input level selects stored data. Figure 1 illustrates the four fundamental bus-management functions that can be performed with the octal bus transceivers and registers

SN54ALS', SN			
,			OR NT PACKAGE
(TOP VIE	: **)	
CLKAB	1 U	24]∨ _{cc}
SAB [2	23] CLKBA
OEAB [3	22] SBA
A1 [4	21] OEBA
A2 [5	20] B1
A3 [6	19] B2
A4 [7	18] B3
A5 [8	17] B4
A6 [9	16] B5
A7 [10	15] B6
A8 [11	14] B7
GND [12	13] в8

SN54ALS', SN54AS' . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

Data on the A or B data bus, or both, can be stored in the internal D-type flip-flops by low-to-high transitions at the appropriate clock (CLKAB or CLKBA) terminals, regardless of the select- or output-control terminals. When SAB and SBA are in the real-time transfer mode, it is possible to store data without using the internal D-type flip-flops by simultaneously enabling OEAB and OEBA. In this configuration, each output reinforces its input. When all other data sources to the two sets of bus lines are at high impedance, each set of bus lines remains at its last state.

The -1 versions of the SN74ALS651A and SN74ALS652A are identical to the standard versions except that the recommended maximum I_{OL} for the -1 versions is increased to 48 mA. There are no -1 versions of the SN54ALS652, SN54ALS653, SN74ALS653, and SN74ALS654.



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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TA	PACK	AGET	ORDERABLE PART NUMBER	TOP-SIDE MARKING					
			SN74ALS651ANT	SN74ALS651ANT					
			SN74ALS652ANT	SN74ALS652ANT					
	PDIP – NT	Tuba	SN74ALS653NT	SN74ALS653NT					
		Tube	SN74ALS654NT	SN74ALS654NT					
			SN74AS651NT	SN74AS651NT					
			SN74AS652NT	SN74AS652NT					
		Tube	SN74ALS651ADW	ALS651A					
	;	Tape and reel	SN74ALS651ADWR	ALSOSTA					
0°C to 70°C		Tube	SN74ALS652ADW	AL 8652A					
0°C to 70°C		Tape and reel	SN74ALS652ADWR	AL3032A					
		Tube	SN74ALS652ADW ALS652A						
	SOIC – DW	Tape and reel	SN74ALS653DWR	AL3033					
		Tube	SN74ALS654DW	AL 9654					
		Tape and reel	SN74ALS654DWR	AL3034					
		Tube	SN74AS651DW	4 9651					
		Tape and reel	SN74AS651DWR	A3031					
		Tube	SN74AS652DW	AS652					
		Tape and reel	SN74AS652DWR	A0052					
			SNJ54ALS652JT	SNJ54ALS652JT					
	CDIP – JT	Tube	SNJ54ALS653JT	SNJ54ALS653JT					
		Tube	SNJ54AS651JT	SNJ54AS651JT					
–55°C to 125°C			SNJ54AS652JT	SNJ54AS652JT					
55 0 10 125 0			SNJ54ALS652FK	SNJ54ALS652FK					
	LCCC – FK	Tube	SNJ54ALS653FK	SNJ54ALS653FK					
			SNJ54AS651FK	SNJ54AS651FK					
			SNJ54AS652FK	SNJ54AS652FK					

ORDERING INFORMATION

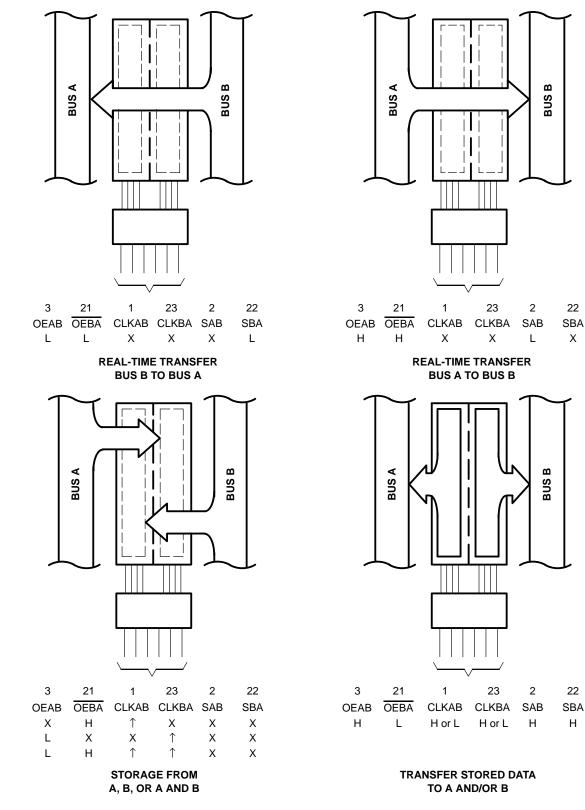
[†]Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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Pin numbers shown are for the DW, JT, and NT packages.

Figure 1. Bus-Management Functions



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Function Tables

0474AE0003, 0474AE0001										
		INPU	ГS			DATA	x 1/0†	OPERATION OR FUNCTION		
OEAB	OEBA	CLKAB	CLKBA	SAB	SBA	A1–A8	B1-B8	OPERATION OR FUNCTION		
L	Н	H or L	H or L	Х	Х	Input	Input	Isolation		
L	Н	\uparrow	\uparrow	Х	х	Input	Input	Store A and B data		
Х	Н	\uparrow	H or L	Х	Х	Input	Unspecified [‡]	Store A, hold B		
Н	Н	\uparrow	\uparrow	x‡	х	Input	Output	Store A in both registers		
L	Х	H or L	Ŷ	Х	Х	Unspecified [‡]	Input	Hold A, store B		
L	L	Ŷ	\uparrow	Х	x‡	Output	Input	Store B in both registers		
L	L	Х	Х	Х	L	Output	Input	Real-time B data to A bus		
L	L	Х	H or L	х	н	Output	Input	Stored B data to A bus		
Н	Н	Х	Х	L	Х	Input	Output	Real-time A data to B bus		
Н	Н	H or L	Х	Н	х	Input	Output	Stored \overline{A} data to B bus		
Н	L	H or L	H or L	Н	Н	Output	Output	Stored A data to B bus and stored B data to A bus		

SN54ALS653, SN54AS651, SN74ALS651A, SN74ALS653, SN74AS651

[†] The data output functions can be enabled or disabled by a variety of level combinations at OEAB or OEBA. Data input functions always are enabled; i.e., data at the bus terminals is stored on every low-to-high transition on the clock inputs.

[‡]Select control = L: clocks can occur simultaneously.

Select control = H: clocks must be staggered to load both registers.

SN54ALS652, SN54AS652, SN74ALS652A, SN74ALS654, SN74AS652

		INPU ⁻	TS			DATA	a 1/o†	OPERATION OR FUNCTION
OEAB	OEBA	CLKAB	CLKBA	SAB	SBA	A1–A8	B1-B8	OPERATION OR FUNCTION
L	Н	H or L	H or L	Х	Х	Input	Input	Isolation
L	Н	Ŷ	\uparrow	Х	х	Input	Input	Store A and B data
Х	Н	1	H or L	Х	Х	Input	Unspecified [‡]	Store A, hold B
Н	н	\uparrow	\uparrow	х‡	х	Input	Output	Store A in both registers
L	Х	H or L	Ŷ	Х	Х	Unspecified [‡]	Input	Hold A, store B
L	L	Ŷ	\uparrow	Х	x‡	Output	Input	Store B in both registers
L	L	Х	Х	Х	L	Output	Input	Real-time B data to A bus
L	L	Х	H or L	Х	Н	Output	Input	Stored B data to A bus
Н	Н	Х	Х	L	Х	Input	Output	Real-time A data to B bus
Н	Н	H or L	Х	Н	х	Input	Output	Stored A data to B bus
Н	L	H or L	H or L	Н	Н	Output	Output	Stored A data to B bus and stored B data to A bus

[†]The data output functions can be enabled or disabled by a variety of level combinations at OEAB or OEBA. Data input functions always are enabled; i.e., data at the bus terminals is stored on every low-to-high transition on the clock inputs.

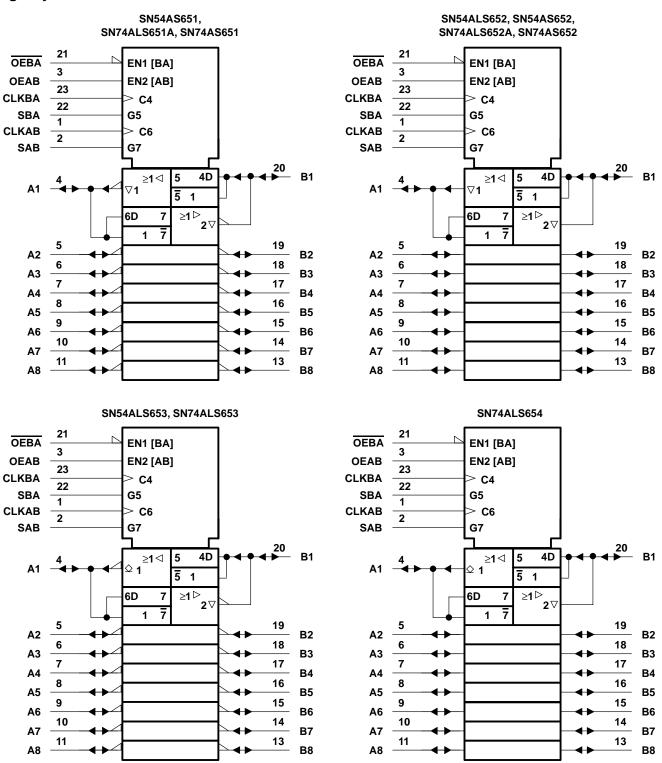
[‡] Select control = L: clocks can occur simultaneously.

Select control = H: clocks must be staggered to load both registers.



SN54ALS652, SN54ALS653, SN54AS651, SN54AS652 SN74ALS651A, SN74ALS652A, SN74ALS653, SN74ALS654, SN74AS651, SN74AS652 OCTAL BUS TRANSCEIVERS AND REGISTERS WITH 3-STATE OUTPUTS SDAS066G - DECEMBER 1983 - REVISED DECEMBER 2000

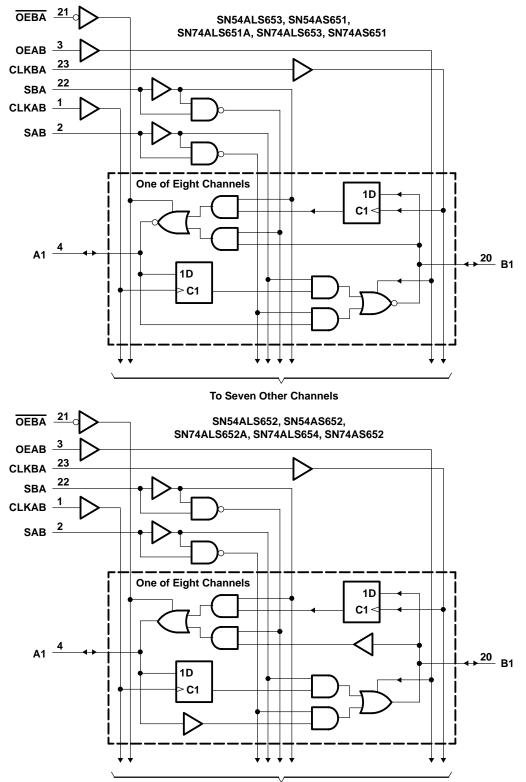
logic symbols[†]



[†] These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the DW, JT, and NT packages.

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logic diagrams (positive logic)



To Seven Other Channels

Pin numbers shown are for the DW, JT, and NT packages.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input voltage range, VI: Control inputs	–0.5 V to 7 V
I/O ports	. –0.5 V to 5.5 V
Package thermal impedance, θ_{JA} (see Note 1): DW package	46°C/W
NT package	67°C/W
Storage temperature range, T _{stg}	–65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions

			SN	SN74ALS651A		
			MIN	NOM	MAX	UNIT
VCC	Supply voltage		4.5	5	5.5	V
VIH	High-level input voltage		2			V
VIL	Low-level input voltage					V
ЮН	High-level output current				-15	mA
					24	
^I OL	Low-level output current				48‡	mA
fclock	Clock frequency		0		40	MHz
+	Pulse duration	CLKBA or CLKAB high	12.5			50
tw	Pulse duration	CLKBA or CLKAB low	12.5			ns
t _{su}	Setup time before CLKAB↑ or CLKBA↑	A or B	10			ns
t _h	Hold time after CLKAB \uparrow or CLKBA \uparrow	A or B	0			ns
TA	Operating free-air temperature		0		70	°C

 \ddagger Applies only to the SN74ALS651A-1 and only if V_{CC} is maintained between 4.75 V and 5.25 V

recommended operating conditions

			SN	54ALS6	52	SN74ALS652A		UNIT		
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
VCC	Supply voltage		4.5	5	5.5	4.5	5	5.5	V	
VIH	High-level input voltage		2			2			V	
VIL	Low-level input voltage				0.7			0.8	V	
ЮН	High-level output current				-12			-15	mA	
					12			24		
lOL	Low-level output current							48‡	mA	
fclock	Clock frequency		0		35	0		40	MHz	
1	Pulse duration	CLKBA or CLKAB high	14.5			12.5				
tw	Pulse duration	CLKBA or CLKAB low	14.5			12.5			ns	
t _{su}	Setup time before CLKAB \uparrow or CLKBA \uparrow	A or B	15			10			ns	
th	Hold time after CLKAB \uparrow or CLKBA \uparrow	A or B	5			0			ns	
TA	Operating free-air temperature		-55		125	0		70	°C	

 \pm Applies only to the SN74ALS652A-1 and only if V_{CC} is maintained between 4.75 V and 5.25 V

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

		TEOTO	TEST CONDITIONS			SN74ALS651A			
	PARAMETER	IESIC	ONDITIONS	MIN	TYP [†]	MAX	UNIT		
VIK		V _{CC} = 4.5 V,	lj = – 18 mA			-1.2	V		
		V _{CC} = 4.5 V to 5.5 V,	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -	2				
Vон		V _{CC} = 4.5 V	$I_{OH} = -3 \text{ mA}$	2.4	3.2		V		
		VCC = 4.5 V	I _{OH} = – 15 mA	2					
		V _{CC} = 4.5 V	I _{OL} = 12 mA		0.25	0.4	v		
VOL		VCC = 4.5 V	I _{OL} = 24 mA		0.35	0.5			
		V _{CC} = 4.75 V,	I _{OL} = 48 mA (-1 versions)		0.35	0.5			
1.	Control inputs	V _{CC} = 5.5 V,	V _I = 7 V		0.1		mA		
łı	A or B ports	V _{CC} = 5.5 V,	V _I = 5.5 V			0.1	ША		
	Control inputs		V 07V			20	•		
Ιн	A or B ports‡	V _{CC} = 5.5 V,	V _I = 2.7 V			20	μA		
	Control inputs					-0.2			
۱	A or B ports‡	V _{CC} = 5.5 V,	$V_{ } = 0.4 V$			-0.2	mA		
١٥§	-	V _{CC} = 5.5 V,	V _O = 2.25 V	-30		-112	mA		
			Outputs high		42	68			
ICC		V _{CC} = 5.5 V	Outputs low		52	82	82 mA		
			Outputs disabled		52 82				

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

 \ddagger For I/O ports, the parameters I_{IH} and I_{IL} include the off-state output current.

§ The output conditions have been chosen to produce a current that closely approximates one-half of the true short-circuit output current, IOS.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

		TEST CONDITIONS		SN	54ALS6	52	SN7	4ALS65	52A		
P	ARAMETER	IESI	CONDITIONS	MIN	TYP [†]	MAX	MIN	TYP [†]	MAX	UNIT	
VIK		V _{CC} = 4.5 V,	lj = – 18 mA			-1.2			-1.2	V	
		V _{CC} = 4.5 V to 5.5 V,	I _{OH} = -0.4 mA	V _{CC} -2			V _{CC} -2				
V			I _{OH} = -3 mA	2.4	3.2		2.4	3.2		V	
^V OH	V _{CC} = 4.5 V	I _{OH} = -12 mA	2						v		
			I _{OH} = -15 mA				2				
			I _{OL} = 12 mA		0.25	0.4		0.25	0.4		
VOL	VOL	$V_{CC} = 4.5 V$	I _{OL} = 24 mA					0.35	0.5	V	
		V _{CC} = 4.75 V,	I _{OL} = 48 mA (-1 versions)					0.35	0.5		
1.	Control inputs	V _{CC} = 5.5 V,	V _I = 7 V			0.1			0.1	A	
1	A or B ports	V _{CC} = 5.5 V,	V _I = 5.5 V			0.1			0.1	mA	
	Control inputs					20			20		
ΙΗ	A or B ports‡	V _{CC} = 5.5 V,	V _I = 2.7 V			20			20	μA	
	Control inputs					-0.2			-0.2	-	
۱L	A or B ports‡	V _{CC} = 5.5 V,	V _I = 0.4 V			-0.2			-0.2	mA	
IO§	•	V _{CC} = 5.5 V,	V _O = 2.25 V	-20		-112	-30		-112	mA	
-			Outputs high		47	76		47	76		
ICC		V _{CC} = 5.5 V	Outputs low		55	88		55	88	mA	
			Outputs disabled		55	88		55	88		

[†] All typical values are at V_{CC} = 5 V, T_A = 25°C. [‡] For I/O ports, the parameters I_{IH} and I_{IL} include the off-state output current.

§ The output conditions have been chosen to produce a current that closely approximates one-half of the true short-circuit output current, IOS.



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switching characteristics (see Figure 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	C _L = 50 pF R1 = 500 G R2 = 500 G T _A = MIN t	$V_{CC} = 4.5 V \text{ to } 5.5 V,$ $C_{L} = 50 \text{ pF},$ $R1 = 500 \Omega,$ $R2 = 500 \Omega,$ $T_{A} = \text{MIN to MAX}^{\dagger}$ SN74ALS651A	
			MIN	MAX	
f _{max}			40		MHz
^t PLH	CLKBA or CLKAB	A or B	8	32	ns
^t PHL	CERBA OF CERAB	AUB	5	17	115
^t PLH	A or B	B or A	2	18	ns
^t PHL			2	10	
^t PLH	SBA or SAB‡	A or B	8	38	ns
^t PHL	(with A or B high)		6	21	
^t PLH	SBA or SAB‡	A or B	8	25	ns
^t PHL	(with A or B low)		7	21	113
^t PZH	0584	A	3	20	ns
^t PZL	OEBA	~	5	18	113
^t PHZ	OEBA	А	2	9	ns
^t PLZ	OEBA	~	3	12	115
^t PZH	OEAB	В	3	22	ns
^t PZL	ULAB	UEAD B		21	115
^t PHZ	OEAB	В	2	12	20
^t PLZ	OLAB	D D	2	14	ns

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡] These parameters are measured with the internal output state of the storage register opposite that of the bus input.



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switching characteristics (see Figure 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	C R R	V _{CC} = 4.5 V to 5.5 V, C _L = 50 pF, R1 = 500 Ω, R2 = 500 Ω, T _A = MIN to MAX [†]				
			SN54A	LS652	SN74AL	S652A		
			MIN	MAX	MIN	MAX		
fmax			35		40		MHz	
^t PLH	CLKBA or CLKAB	A or B	10	35	8	30	ns	
^t PHL		A OLD	5	20	5	17	113	
^t PLH	A or B	B or A	5	20	4	18	ns	
^t PHL		BUIA	3	15	3	12	113	
^t PLH	SBA or SAB‡	A or B	15	40	8	35	ns	
^t PHL	(with A or B high)	AOD	6	23	6	20		
^t PLH	SBA or SAB‡	A or B	8	30	8	25	ns	
^t PHL	(with A or B low)	A OF B	5	24	5	20	ns	
^t PZH	OEBA	А	3	20	3	17	ns	
^t PZL	OEBA	~	5	22	5	18	113	
^t PHZ	OEBA	А	1	12	1	10	ns	
^t PLZ	UEBA		2	20	2	16	115	
^t PZH	OEAB	В	8	25	3	22	ns	
^t PZL			6	21	5	18	115	
^t PHZ	OEAB	В	1	12	1	10	ns	
^t PLZ	OLAB	B	2	21	2	16	115	

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡]These parameters are measured with the internal output state of the storage register opposite that of the bus input.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}	
Input voltage range, V _I : Control inputs	–0.5 V to 7 V
I/O ports	–0.5 V to 5.5 V
Package thermal impedance, θ _{JA} (see Note 1): DW package	46°C/W
NT package	67°C/W
Storage temperature range, T _{stg}	–65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions

			SN	54ALS6	53	SN74ALS653		53	UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage		4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage		2			2			V
VIL	Low-level input voltage				0.7			0.8	V
VOH	High-level output voltage	A ports			5.5			5.5	V
ЮН	High-level output current	B ports			-12			-15	mA
IOL	Low-level output current				12			24	mA
fclock	Clock frequency		0		25	0		35	MHz
	Pulse duration	CLKBA or CLKAB high	20			14.5			
tw	Pulse duration	CLKBA or CLKAB low	20			14.5			ns
t _{su}	Setup time before CLKAB \uparrow or CLKBA \uparrow	A or B	15			10			ns
t _h	Hold time after CLKAB \uparrow or CLKBA \uparrow	A or B	5			0			ns
Т _А	Operating free-air temperature		-55		125	0		70	°C

recommended operating conditions

			SN	SN74ALS654		
			MIN	NOM	MAX	UNIT
Vcc	Supply voltage		4.5	5	5.5	V
VIH	High-level input voltage		2			V
VIL	Low-level input voltage				0.8	V
VOH	High-level output voltage	A ports			5.5	V
ЮН	High-level output current	B ports			-15	mA
IOL	Low-level output current				24	mA
fclock	Clock frequency		0		35	MHz
	Pulse duration	CLKBA or CLKAB high	14.5			
tw	Pulse duration	CLKBA or CLKAB low	14.5			ns
t _{su}	Setup time before CLKAB↑ or CLKBA↑	A or B	10			ns
^t h	Hold time after CLKAB↑ or CLKBA↑	A or B	0			ns
Т _А	Operating free-air temperature		0		70	°C



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

-		тгот	CONDITIONS	SN	54ALS6	53	SN	74ALS6	53		
P/	ARAMETER	TEST CONDITIONS		MIN	TYP [†]	MAX	MIN	түр†	MAX	UNIT	
VIK		V _{CC} = 4.5 V,	lj = – 18 mA			-1.2			-1.2	V	
		V_{CC} = 4.5 V to 5.5 V,	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2			$V_{CC}-2$				
V	V _{OH} B ports		$I_{OH} = -3 \text{ mA}$	2.4	3.2		2.4	3.2		v	
VOH D ports	$V_{CC} = 4.5 V$	$I_{OH} = -12 \text{ mA}$	2						v		
			I _{OH} = -15 mA				2				
Vai			I _{OL} = 12 mA		0.25	0.4		0.25	0.4	v	
VOL		$V_{CC} = 4.5 V$	I _{OL} = 24 mA					0.35	0.5		
1.	Control inputs	V _{CC} = 5.5 V,	V _I = 7 V			0.1			0.1	0.1 mA	
lj –	A or B ports	V _{CC} = 5.5 V,	V _I = 5.5 V			0.1			0.1	mA	
	Control inputs		N 07.V			20			20	•	
ЧН	A or B ports‡	V _{CC} = 5.5 V,	$V_{\rm CC} = 5.5 \text{ V}, \qquad V_{\rm I} = 2.7 \text{ V}$			20			20	μA	
	Control inputs		N 0.4 M			-0.2			-0.2		
ΊL	A or B ports‡	V _{CC} = 5.5 V,	V _I = 0.4 V			-0.2			-0.2	mA	
ЮН	A ports	V _{CC} = 4.5 V,	V _{OH} = 5.5 V			0.1			0.1	mA	
۱ ₀ §	B ports	V _{CC} = 5.5 V,	V _O = 2.25 V	-20		-112	-30		-112	mA	
	•		Outputs high		47	76		47	76		
ICC	V _{CC} = 5.5 V	Outputs low		55	88		55	88	mA		
			Outputs disabled		55	88		55	88		

[†] All typical values are at V_{CC} = 5 V, T_A = 25°C. [‡] For I/O ports, the parameters I_{IH} and I_{IL} include the off-state output current.

§ The output conditions have been chosen to produce a current that closely approximates one-half of the true short-circuit output current, IOS.



SDAS066G - DECEMBER 1983 - REVISED DECEMBER 2000

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	DADAMETED	TEAT OF		SN	54			
	PARAMETER	IESICO	ONDITIONS	MIN	TYP [†]	MAX	UNIT	
VIK		V _{CC} = 4.5 V,	lj = –18 mA			-1.2	V	
		V _{CC} = 4.5 V to 5.5 V,	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2				
Vон	B ports		$I_{OH} = -3 \text{ mA}$	2.4	3.2		V	
		V _{CC} = 4.5 V	I _{OH} = -15 mA	2				
Vai			I _{OL} = 12 mA		0.25	0.4	V	
VOL		V _{CC} = 4.5 V	I _{OL} = 24 mA		0.35	0.5		
L.	Control inputs	V _{CC} = 5.5 V,	V _I = 7 V			0.1	mA	
lj	A or B ports	V _{CC} = 5.5 V,	VI = 5.5 V			0.1	ША	
	Control inputs		N/ 07/			20	•	
ΙΗ	A or B ports‡	$V_{CC} = 5.5 V,$	V _I = 2.7 V	20			μΑ	
	Control inputs		N/ 0.4.V/			-0.2		
ΊĽ	A or B ports‡	$V_{CC} = 5.5 V,$	$V_{1} = 0.4 V$	V _I = 0.4 V		-0.2	mA	
IOH	A ports	V _{CC} = 4.5 V,	V _{OH} = 5.5 V			0.1	mA	
۱ ₀ §	B ports	V _{CC} = 5.5 V,	V _O = 2.25 V	-30		-112	mA	
	•		Outputs high		47	76		
ICC	Vcc	V _{CC} = 5.5 V	Outputs low		55	88	mA	
			Outputs disabled		55	88		

[†] All typical values are at $V_{CC} = 5 V$, $T_A = 25^{\circ}C$.

[‡] For I/O ports, the parameters I_{IH} and I_{IL} include the off-state output current.

§ The output conditions have been chosen to produce a current that closely approximates one-half of the true short-circuit output current, IOS.



SDAS066G - DECEMBER 1983 - REVISED DECEMBER 2000

switching characteristics (see Figure 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	C _L = 50 R _L = 68 R1 = R2	$V_{CC} = 4.5 V \text{ to } 5.5 V,$ $C_L = 50 \text{ pF},$ $R_L = 680 \Omega \text{ (A outputs)},$ $R1 = R2 = 500 \Omega \text{ (B outputs)},$ $T_A = \text{MIN to MAX}^{\dagger}$					
			SN54A	SN54ALS653		LS653			
			MIN	MAX	MIN	MAX			
fmax			25		35		MHz		
^t PLH	CLKBA	А	16	71	16	64	ns		
^t PHL	CERDA	~	6	24	6	22	115		
^t PLH	CLKAB	В	10	35	10	30	ns		
^t PHL	CEIVAD	ļ	5	20	5	17	115		
^t PLH	A	В	5	20	5	18	ns		
^t PHL	~	D	1.5	18	2	15	115		
^t PLH	в	А	8	63	12	56	ns		
^t PHL	В	~	2	18	2	15	115		
^t PLH	SBA‡	А	12	68	19	62	ns		
^t PHL	(with B high)	~	5	27	5	25	115		
^t PLH	SBA‡	А	12	68	19	62	ns		
^t PHL	(with B low)	~	5	27	5	25	115		
^t PLH	SAB‡	В	8	30	15	35	ns		
^t PHL	(with A high)	В	6	25	6	22	115		
^t PLH	SAB‡	В	12	40	8	25	ns		
^t PHL	(with A low)	D	6	25	6	22	115		
^t PLH		А	6	35	6	30	ns		
^t PHL	OEBA	A	6	27	6	24	115		
^t PZH	OEAB	В	7	25	8	22	200		
^t PZL		D	6	25	6	22	ns		
^t PHZ	OEAB	В	1	16	1	14			
^t PLZ		В	2	21	2	16	ns		

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡] These parameters are measured with the internal output state of the storage register opposite that of the bus input.



SDAS066G - DECEMBER 1983 - REVISED DECEMBER 2000

switching characteristics (see Figure 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 4.5 V \text{ to } 5.5 V,$ $C_{L} = 50 \text{ pF},$ $R_{L} = 680 \Omega \text{ (A outputs)},$ $R1 = R2 = 500 \Omega \text{ (B outputs)},$ $T_{A} = \text{MIN to MAX}^{\dagger}$ $SN74ALS654$	UNIT
			MIN MAX	
fmax			35	MHz
^t PLH	СЬКВА	А	16 64	ns
^t PHL	OERBA	~	6 22	113
^t PLH	CLKAB	В	10 30	ns
^t PHL	OLIVID	Б	5 17	113
^t PLH	A	В	5 18	ns
^t PHL	~	В	2 15	113
^t PLH	в	А	12 56	ns
^t PHL	в	A	2 21	115
^t PLH	SBA‡	А	19 62	ns
^t PHL	(with B low)	~	5 25	113
^t PLH	SBA‡	А	19 62	ns
^t PHL	(with B high)	A	5 25	115
^t PLH	SAB [‡]	В	15 35	ns
^t PHL	(with A low)	В	6 22	113
^t PLH	SAB‡	В	8 25	ns
^t PHL	(with A high)	В	6 22	115
^t PLH	OEBA	А	6 30	ns
^t PHL	UEBA	~	6 24	115
^t PZH	OEAB	В	6 22	ns
^t PZL	ULAD		6 22	115
^t PHZ	OEAB	В	1 14	200
^t PLZ	ULAD		2 16	ns

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡]These parameters are measured with the internal output state of the storage register opposite that of the bus input.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}	\ldots –0.5 V to 7 V
Input voltage range, VI: Control inputs	\ldots –0.5 V to 7 V
I/O ports	–0.5 V to 5.5 V
Package thermal impedance, θ _{JA} (see Note 1): DW package	46°C/W
NT package	67°C/W
Storage temperature range, T _{stg}	–65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions

			_	N54AS65 N54AS65		SN74AS651 SN74AS652		UNIT	
			MIN	NOM	MAX	MIN	NOM	MAX	
VCC	Supply voltage		4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage		2			2			V
VIL	Low-level input voltage				0.8			0.8	V
ЮН	High-level output current				-12			-15	mA
IOL	Low-level output current	Low-level output current			32			48	mA
fclock	Clock frequency		0*		75*	0		90	MHz
	Dulas duration	CLKBA or CLKAB high	6*			5			20
tw	Pulse duration	CLKBA or CLKAB low	7*			6			ns
t _{su}	Setup time before CLKAB \uparrow or CLKBA \uparrow	A or B	7*			6			ns
t _h	Hold time after CLKAB↑ or CLKBA	A or B	0*			0			ns
Тд	Operating free-air temperature		-55		125	0		70	°C

* On products compliant to MIL-PRF-38535, this parameter is based on characterized data but is not production tested.



SDAS066G - DECEMBER 1983 - REVISED DECEMBER 2000

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

P/	ARAMETER	TEST C	TEST CONDITIONS		154AS65 154AS65		-	N74AS65		UNIT
				MIN	TYP [†]	MAX	MIN	TYP†	MAX	
VIK		V _{CC} = 4.5 V,	lj = – 18 mA			-1.2			-1.2	V
		V_{CC} = 4.5 V to 5.5 V,	$I_{OH} = -2 \text{ mA}$	V _{CC} -2	2		V _{CC} -2	2		
Val			I _{OH} = -3 mA	2.4	3.2		2.4	3.2		V
Vон	$V_{CC} = 4.5 V$	I _{OH} = -12 mA	2						v	
			I _{OH} = -15 mA				2			
Val			I _{OL} = 32 mA		0.25	0.5				V
VOL		V _{CC} = 4.5 V	I _{OL} = 48 mA					0.35	0.5	0.5
I.	Control inputs	V _{CC} = 5.5 V,	V _I = 7 V			0.1			0.1	0.1 mA
tı	A or B ports	V _{CC} = 5.5 V,	V _I = 5.5 V			0.1			0.1	
	Control inputs					20			20	
ΙΗ	A or B ports‡	V _{CC} = 5.5 V,	V _I = 2.7 V			70			70	μA
	Control input					-0.5			-0.5	
۱	A or B ports‡	$V_{CC} = 5.5 V,$	$V_{\rm CC} = 5.5 \text{ V}, \qquad V_{\rm I} = 0.4 \text{ V}$			-0.75			-0.75	mA
۱ ₀ §		V _{CC} = 5.5 V,	V _O = 2.25 V	-30		-112	-30		-112	mA
			Outputs high		110	185		110	185	
	'AS651	V _{CC} = 5.5 V	Outputs low		120	195		120	195	
1			Outputs disabled		130	195		130	195	
lcc			Outputs high		120	195		120	195	mA
	'AS652	V _{CC} = 5.5 V	Outputs low		130	211		130	211	
			Outputs disabled		130	211		130	211	

[†] All typical values are at V_{CC} = 5 V, T_A = 25 °C. [‡] For I/O ports, the parameters I_{IH} and I_{IL} include the off-state output current.

\$ The output conditions have been chosen to produce a current that closely approximates one-half of the true short-circuit output current, IOS.



SDAS066G - DECEMBER 1983 - REVISED DECEMBER 2000

switching characteristics (see Figure 2)

PARAMETER	FROM (INPUT)				V_{CC} = 4.5 V to 5.5 V, C _L = 50 pF, R1 = 500 Ω, R2 = 500 Ω, T _A = MIN to MAX [†]				
			SN54A	S651	SN74A	S651			
			MIN	MAX	MIN	MAX			
fmax			75*		90		MHz		
^t PLH	CLKBA or CLKAB	A or B	2	11	2	8.5	20		
^t PHL		AUB	2	10	2	9	ns		
^t PLH	A or B	B or A	2	12	2	8	ns		
^t PHL	A OF D	BUIA	1	8	1	7			
^t PLH	SBA or SAB‡	A or B	2	15	2	11	ns		
^t PHL	SBA UI SAB+	AUD	2	11	2	9	115		
^t PZH	OEBA	A	2	11	2	10	ns		
^t PZL	UEBA	~	3	18	3	16	115		
^t PHZ	OEBA	А	2	10	2	9	ns		
^t PLZ	OEBA	~	2	10	2	9	115		
^t PZH	OEAB	В	3	12	3	11	ns		
^t PZL			3	20	3	16	113		
^t PHZ	OEAB	В	2	11	2	10	ns		
^t PLZ			2	12	2	11	115		

* On products compliant to MIL-PRF-38535, this parameter is based on characterized data but is not production tested.

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡]These parameters are measured with the internal output state of the storage register opposite that of the bus input.



SDAS066G - DECEMBER 1983 - REVISED DECEMBER 2000

switching characteristics (see Figure 2)

PARAMETER	FROM (INPUT)	то (оитрит)	V _C	UNIT			
			SN54A	S652	SN74A	S652	
			MIN	MAX	TYP	MAX	
fmax			75*		90		MHz
^t PLH	CLKBA or CLKAB	A or B	2	11	2	8.5	200
^t PHL	CERBA OF CERAB	AGE	2	10	2	9	ns
^t PLH	A or B	B or A	2	12	2	9	ns
^t PHL		B of A	1	8	1	7	113
^t PLH	SBA or SAB‡	A or B	2	15	2	11	ns
^t PHL	SBA OF SAB+	AUB	2	11	2	9	115
^t PZH	OEBA	А	2	11	2	10	ns
^t PZL	OEBA	A	3	18	3	16	115
^t PHZ	0504	А	2	10	2	9	ns
^t PLZ	OEBA	Α	2	10	2	9	115
^t PZH	OEAB	В	3	12	3	11	200
^t PZL	UEAD	D	3	20	3	16	ns
^t PHZ	OEAB	В	2	11	2	10	-
^t PLZ	UEAD	D	2	12	2	11	ns

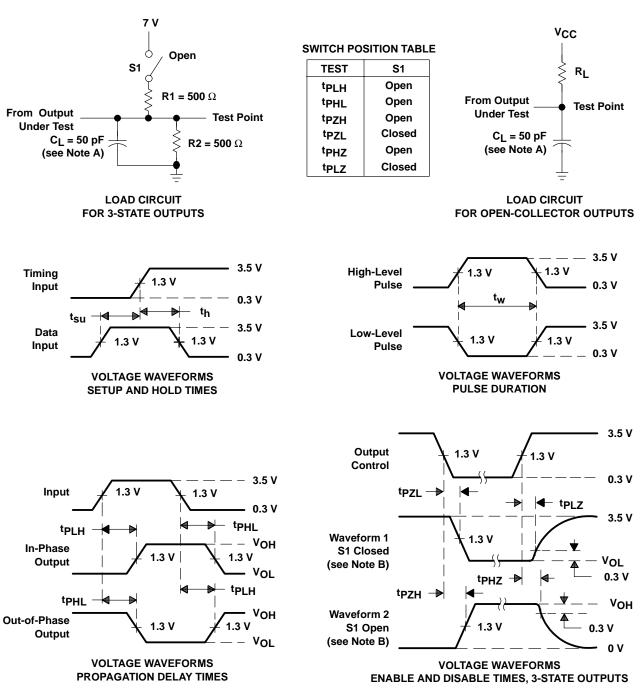
* On products compliant to MIL-PRF-38535, this parameter is based on characterized data but is not production tested.

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡]These parameters are measured with the internal output state of the storage register opposite that of the bus input.



SN54ALS652, SN54ALS653, SN54AS651, SN54AS652 SN74ALS651A, SN74ALS652A, SN74ALS653, SN74ALS654, SN74AS651, SN74AS652 **OCTAL BUS TRANSCEIVERS AND REGISTERS WITH 3-STATE OUTPUTS** SDAS066G - DECEMBER 1983 - REVISED DECEMBER 2000



PARAMETER MEASUREMENT INFORMATION

NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z₀ = 50 Ω , t_f \leq 2 ns, t_f \leq 2 ns.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 2. Load Circuits and Voltage Waveforms





PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
5962-88673013A	ACTIVE	LCCC	FK	28	42	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 88673013A SNJ54ALS 652FK	Samples
5962-8867301LA	ACTIVE	CDIP	JT	24	15	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8867301LA SNJ54ALS652JT	Samples
5962-8868701LA	ACTIVE	CDIP	JT	24	15	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8868701LA SNJ54AS652JT	Samples
5962-89687013A	ACTIVE	LCCC	FK	28	42	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 89687013A SNJ54ALS 653FK	Samples
5962-8968701LA	ACTIVE	CDIP	JT	24	15	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8968701LA SNJ54ALS653JT	Samples
SN54ALS652JT	ACTIVE	CDIP	JT	24	15	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	SN54ALS652JT	Samples
SN54AS652JT	ACTIVE	CDIP	JT	24	15	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	SN54AS652JT	Samples
SN74ALS652A-1DW	ACTIVE	SOIC	DW	24	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	ALS652A-1	Samples
SN74ALS652ADW	ACTIVE	SOIC	DW	24	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	ALS652A	Samples
SN74ALS652ADWR	ACTIVE	SOIC	DW	24	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	ALS652A	Samples
SN74ALS653DW	ACTIVE	SOIC	DW	24	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	ALS653	Samples
SN74ALS653DWE4	ACTIVE	SOIC	DW	24	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	ALS653	Samples
SN74AS652DW	ACTIVE	SOIC	DW	24	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	AS652	Samples
SNJ54ALS652FK	ACTIVE	LCCC	FK	28	42	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 88673013A SNJ54ALS 652FK	Samples
SNJ54ALS652JT	ACTIVE	CDIP	JT	24	15	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8867301LA SNJ54ALS652JT	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SNJ54ALS653FK	ACTIVE	LCCC	FK	28	42	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 89687013A SNJ54ALS 653FK	Samples
SNJ54ALS653JT	ACTIVE	CDIP	JT	24	15	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8968701LA SNJ54ALS653JT	Samples
SNJ54AS652JT	ACTIVE	CDIP	JT	24	15	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8868701LA SNJ54AS652JT	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF SN54ALS653, SN54AS652, SN74ALS653, SN74AS652 :

- Catalog : SN74ALS653, SN74AS652
- Military : SN54ALS653, SN54AS652
- NOTE: Qualified Version Definitions:
 - Catalog TI's standard catalog product
 - Military QML certified for Military and Defense Applications

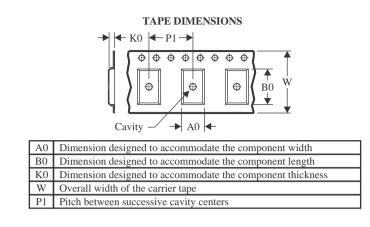


TEXAS

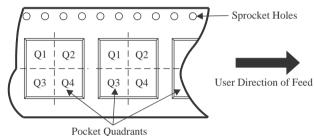
NSTRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ALS652ADWR	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1



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PACKAGE MATERIALS INFORMATION

5-Dec-2023



*All	dimensions	are	nominal	
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Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74ALS652ADWR	SOIC	DW	24	2000	350.0	350.0	43.0

TEXAS INSTRUMENTS

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TUBE



- B - Alignment groove width

*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
SN74ALS652A-1DW	DW	SOIC	24	25	506.98	12.7	4826	6.6
SN74ALS652ADW	DW	SOIC	24	25	506.98	12.7	4826	6.6
SN74ALS653DW	DW	SOIC	24	25	506.98	12.7	4826	6.6
SN74ALS653DWE4	DW	SOIC	24	25	506.98	12.7	4826	6.6
SN74AS652DW	DW	SOIC	24	25	506.98	12.7	4826	6.6

MECHANICAL DATA

MCER004A - JANUARY 1995 - REVISED JANUARY 1997

JT (R-GDIP-T**)

CERAMIC DUAL-IN-LINE

24 LEADS SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification.
- E. Falls within MIL STD 1835 GDIP3-T24, GDIP4-T28, and JEDEC MO-058 AA, MO-058 AB



LEADLESS CERAMIC CHIP CARRIER

FK (S-CQCC-N**) 28 TERMINAL SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. This package can be hermetically sealed with a metal lid.

D. Falls within JEDEC MS-004



DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AD.



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